

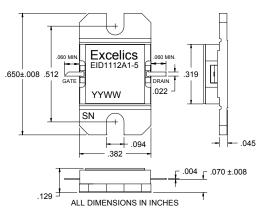
EID1112A1-5

UPDATED 07/12/2007

11.70-12.70 GHz 5-Watt Internally Matched Power FET

FEATURES

- 11.70-12.70 GHz Bandwidth
- Input/Output Impedance Matched to 50 Ohms
- +37.5 dBm Output Power at 1dB Compression
- 8.0 dB Power Gain at 1dB Compression
- 35% Power Added Efficiency
- Hermetic Metal Flange Package
- 100% Tested for DC, RF, and R_{TH}



ELECTRICAL CHARACTERISTICS ($T_a = 25$ °C)



Caution! ESD sensitive device.

SYMBOL	PARAMETERS/TEST CONDITIONS ¹	MIN	TYP	MAX	UNITS
P _{1dB}	Output Power at 1dB Compression $f = 11.70-12.70GHz$ $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 1200\text{mA}$	37.0	37.5		dBm
G _{1dB}	Gain at 1dB Compression $f = 11.70-12.70GHz$ $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 1200\text{mA}$	7.0	8.0		dB
ΔG	Gain Flatness $f = 11.70-12.70GHz$ $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 1200\text{mA}$			±0.6	dB
PAE	Power Added Efficiency at 1dB Compression $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 1200 \text{mA}$ f = 11.70-12.70GHz		35		%
Id _{1dB}	Drain Current at 1dB Compression f = 11.70-12.70GHz		1400	1800	mA
I _{DSS}	Saturated Drain Current V _{DS} = 3 V, V _{GS} = 0 V		2300	2800	mA
V _P	Pinch-off Voltage V _{DS} = 3 V, I _{DS} = 24 mA		-1.2	-2.5	V
R _{TH}	Thermal Resistance ³		5.5	6.0	°C/W

Notes: 1. Tested with 100 Ohm gate resistor.

ABSOLUTE MAXIMUM RATINGS FOR CONTINUOUS OPERATION^{1,2}

SYMBOL	CHARACTERISTIC	VALUE	
V_{DS}	Drain to Source Voltage	10 V	
V_{GS}	Gate to Source Voltage	-3.0 V	
I _{DS}	Drain Current	IDSS	
I_{GSF}	Forward Gate Current	40 mA	
P _{IN}	Input Power	@ 3dB compression	
P_T	Total Power Dissipation	20 W	
T _{CH}	Channel Temperature	150°C	
T _{STG}	Storage Temperature	-65/+150°C	

Note: 1. Exceeding any of the above ratings may result in permanent damage.

^{2.} Overall Rth depends on case mounting.

^{2.} Exceeding any of the above ratings may reduce MTTF below design goals.



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- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness